



UNIVERSITI PUTRA MALAYSIA

**PREPARATION AND CHARACTERIZATION OF MONO-DIMENSIONAL OXIDE ION CONDUCTORS IN  $\text{Bi}_2\text{O}_3\text{MoO}_3$  SYSTEM**

**LIM CHIA MENG  
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**By**

**LIM CHIA MENG**

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OXIDE ION CONDUCTORS IN  $\text{Bi}_2\text{O}_3\text{MoO}_3$  SYSTEM**

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A new family of mono-dimensional oxide ion conductors with a formula  $x\text{Bi}_2\text{O}_3:\text{MoO}_3$  has been prepared by three different methods: solid state, mechanochemical and *n*-butylamine method. X-ray powder diffraction (XRPD) analysis showed that materials with compositions  $\text{Bi}_x\text{Mo}_{10}\text{O}_\delta$  ( $25.5 \leq x \leq 27.5$ ) prepared by solid state method formed high-temperature (HT) phase after heating at  $800^\circ\text{C}$  for 48 hours. With mechanochemical and *n*-butylamine methods, the lower limit of solid solution was  $x = 25$ . In the mechanochemical method, HT- $\text{Bi}_{26}\text{Mo}_{10}\text{O}_{69}$  was obtained after milling at 1400 rpm for 1 hour, followed by heating at  $800^\circ\text{C}$  for only 1 hour or  $750^\circ\text{C}$  for 24 hours. With *n*-butylamine method, the reaction product had to be heated at  $800^\circ\text{C}$  for 48 hours to yield a phase pure HT- $\text{Bi}_{26}\text{Mo}_{10}\text{O}_{69}$ . All the peaks in the XRPD patterns of HT-phase materials can be fully indexed in a monoclinic symmetry with space group  $P2/c$ . Materials of compositions  $27 \leq x \leq 31$  appears to form a low-temperature (LT) phase after being heated at  $650^\circ\text{C}$  for 48 hours. For LT-phase materials, the XRPD patterns were fully indexed in a monoclinic symmetry with space group  $P2_1/a$ .

Electrical properties of phase pure materials were determined using impedance spectroscopy. From the results, HT-Bi<sub>26</sub>Mo<sub>10</sub>O<sub>69</sub> prepared by mechanochemical and *n*-butylamine methods exhibited higher conductivity values compared to that prepared via solid-state method in the temperature range of 200-300°C. HT-Bi<sub>27</sub>Mo<sub>10</sub>O<sub>70.5</sub> prepared by solid state method exhibited highest conductivity among the HT-phase solid solutions. There was, however, no difference in conductivity for HT-Bi<sub>27</sub>Mo<sub>10</sub>O<sub>70.5</sub> prepared by the three different methods. The high-temperature polymorph of Bi<sub>27</sub>Mo<sub>10</sub>O<sub>70.5</sub> exhibited higher conductivity than the low-temperature polymorph.

Doping was carried out on the Mo site of HT-Bi<sub>27</sub>Mo<sub>10</sub>O<sub>70.5</sub> with selected dopants, i.e. Al, Cr, Ge, Si, Sn, Zr, As, Nb, Sb and W. All dopants could be introduced into Bi<sub>27</sub>Mo<sub>10</sub>O<sub>70.5</sub> with rather limited solid solutions. Bi<sub>27</sub>Mo<sub>9.5</sub>Zr<sub>0.5</sub>O<sub>70</sub> gave a conductivity value one order higher than the parent material Bi<sub>27</sub>Mo<sub>10</sub>O<sub>70.5</sub>. No significant difference in conductivity was observed for other doped materials compared to the parent material Bi<sub>27</sub>Mo<sub>10</sub>O<sub>70.5</sub>.

The stoichiometric composition of phase pure materials was confirmed by inductively coupled plasma-optical emission spectrometry (ICP-OES). The phase transition of triclinic-monoclinic for HT-Bi<sub>x</sub>MO<sub>10</sub>O<sub>δ</sub> ( $25.5 \leq x \leq 27$ ) was observed in differential thermal analysis (DTA) and differential scanning calorimetry (DSC). No thermal event was observed for doped materials, except Bi<sub>27</sub>Mo<sub>9.8</sub>W<sub>0.2</sub>O<sub>70.5</sub>. No weight loss of phase pure materials was observed in the thermogravimetric analysis (TGA).

Scanning electron microscopy (SEM) experiments showed that the grain size of single phase materials was in the range of 10 – 20  $\mu\text{m}$ , with low porosity. The straight-line plots of density versus x in  $\text{Bi}_x\text{Mo}_{10}\text{O}_\delta$  solid solutions indicated that Vegard's law was obeyed. Absorptions in the far IR region (400 – 1000  $\text{cm}^{-1}$ ) due to the vibration of Mo-O bond were observed in Fourier-transform infrared (FT-IR) spectroscopy.

Abstrak tesis yang dikemukakan kepada Senat Universiti Putra Malaysia sebagai memenuhi keperluan untuk ijazah Master Sains

**PENYEDIAAN DAN PENCIRIAN SATU DIMENSI KONDUKTOR ION OKSIDA DALAM  $\text{Bi}_2\text{O}_3\text{MoO}_3$  SISTEM**

Oleh

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Konduktor ion oksida jenis mono-dimensi dalam keluarga baru dengan formula  $x\text{Bi}_2\text{O}_3 \cdot \text{MoO}_3$  telah disediakan dengan tiga cara yang berlainan: tindak balas keadaan pepejal, mekanokimia dan *n*-butilamina. Analisis pembelauan serbuk sinar-x (XRPD) menunjukkan bahawa bahan-bahan dengan komposisi  $\text{Bi}_x\text{Mo}_{10}\text{O}_{\delta}$  ( $1.275 \leq x \leq 1.375$ ) yang disintesis melalui cara tindak balas keadaan pepejal adalah dalam fasa suhu tinggi (HT-phase) selepas dipanaskan pada  $800^\circ\text{C}$  selama 48 jam. Manakala dengan cara-cara mekanokimia dan *n*-butilamina, larutan pepejal terendah mempunyai komposisi dengan  $x = 1.25$ . Bahan-bahan berkomposisi  $1.35 \leq x \leq 1.55$  adalah dalam fasa suhu rendah (LT-phase) selepas dipanaskan pada  $650^\circ\text{C}$  selama 48 jam. HT- $\text{Bi}_{26}\text{Mo}_{10}\text{O}_{69}$  (bahan induk) telah dihasilkan selepas penginciran pada 1400 rpm selama 1 jam, diikuti dengan pemanasan pada  $800^\circ\text{C}$  selama 1 jam atau  $750^\circ\text{C}$  selama 24 jam. Dengan cara *n*-butilamina, bahan tindak balas perlu dipanaskan pada  $800^\circ\text{C}$  selama 48 jam untuk menghasilkan fasa tulen HT- $\text{Bi}_{26}\text{Mo}_{10}\text{O}_{69}$ . Semua puncak dalam data XRPD bagi bahan-bahan berfasa suhu tinggi boleh diindeks sepenuhnya dalam simetri monoklinik dengan kumpulan ruang  $P2/c$ . Untuk bahan-

bahan berfasa suhu rendah, XRPD data telah diindeks sepenuhnya dalam simetri monoklinik dengan kumpulan ruang  $P2_1/a$ .

Kekonduksian bagi bahan-bahan berfasa tulen telah diukur dengan menggunakan spektroskopi impedans. HT- $\text{Bi}_{26}\text{Mo}_{10}\text{O}_{69}$  yang disediakan melalui cara-cara mekanikal kimia dan *n*-butilamina telah menunjukkan nilai kekonduksian yang tertinggi pada suhu antara 200-300°C berbanding dengan HT- $\text{Bi}_{26}\text{Mo}_{10}\text{O}_{69}$  yang disediakan melalui cara tindak balas keadaan pepejal. HT- $\text{Bi}_{27}\text{Mo}_{10}\text{O}_{70.5}$  menunjukkan kekonduksian tertinggi antara bahan-bahan berfasa suhu tinggi yang disediakan melalui cara tindak balas keadaan pepejal. Namun, tiada perbezaan kekonduksian antara bahan-bahan berkomposisi HT- $\text{Bi}_{27}\text{Mo}_{10}\text{O}_{70.5}$  yang disediakan melalui tiga cara yang berlainan.  $\text{Bi}_{27}\text{Mo}_{10}\text{O}_{70.5}$  berfasa suhu tinggi menunjukkan kekonduksian yang tinggi berbanding dengan  $\text{Bi}_{27}\text{Mo}_{10}\text{O}_{70.5}$  berfasa suhu rendah.

Proses pendopan dengan pelbagai dopan, termasuk Al, Cr, Ge, Si, Sn, Zr, As, Nb, Sb dan W, telah dijalankan untuk HT- $\text{Bi}_{27}\text{Mo}_{10}\text{O}_{70.5}$ . Semua jenis dopan boleh didopkan ke dalam  $\text{Bi}_{27}\text{Mo}_{10}\text{O}_{70.5}$  dengan larutan pepejal yang agak terhad.  $\text{Bi}_{27}\text{Mo}_{9.5}\text{Zr}_{0.5}\text{O}_{70}$  memberikan nilai kekonduksian satu tertib lebih tinggi berbanding dengan bahan induk  $\text{Bi}_{27}\text{Mo}_{10}\text{O}_{70.5}$ . Tiada perbezaan yang ketara dalam kekonduksian bagi bahan-bahan didopkan berbanding bahan induk  $\text{Bi}_{27}\text{Mo}_{10}\text{O}_{70.5}$ .

Komposisi stoikiometri bagi bahan-bahan berfasa tulen telah ditentukan melalui eksperimen plasma aruhan gandaan-spektroskopi penyebaran optik (ICP-OES). Perubahan fasa antara trikilnik –monoklinik bagi HT- $\text{Bi}_x\text{MO}_{10}\text{O}_{\delta}$  ( $25.5 \leq x \leq 27$ ) telah didapati dalam analisis pembezaan terma (DTA) dan kalorimetri pembezaan

pengimbasan (DSC). Tiada peristiwa terma bagi bahan-bahan didopkan, kecuali  $\text{Bi}_{27}\text{Mo}_{9.8}\text{W}_{0.2}\text{O}_{70.5}$ . Didapati tiada kehilangan jisim bagi bahan-bahan berfasa tulen dalam analisis thermogravimetri (TGA).

Ujian imbasan elektron mikrograf (SEM) menunjukkan saiz butir-butiran bagi setiap bahan adalah dalam lingkungan  $10 - 20 \mu\text{m}$ , dengan keliangan yang rendah. Plot gengan garisan lurus untuk ketumpatan lawan nilai  $x$  dalam larutan pepejal  $\text{Bi}_x\text{Mo}_{10}\text{O}_\delta$  menunjukkan bahawa Hukum Vegard adalah dipatuhi. Penyerapan dalam IR berlingkungan jauh ( $400 - 1000 \text{ cm}^{-1}$ ) yang disebabkan oleh getaran ikatan Mo-O telah didapati dalam spektroskopi inframerah transformasi Fourier (FT-IR).

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Date: 21 February 2008

## **DECLARATION**

I hereby declare that the thesis is based on my original work except for quotations and citations which have been duly acknowledged. I also declare that it has not been previously or concurrently submitted for any other degree at UPM or other institutions.

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**LIM CHIA MENG**

Date:



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**Bi<sub>27</sub>Mo<sub>10-x</sub>W<sub>x</sub>O<sub>δ</sub> (0 ≤ x ≤ 1.1)**

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## **LIST OF ABBREVIATIONS/NOTATIONS/GLOSSARY OF TERMS**

|                |  |
|----------------|--|
| ac             | alternating current                                      |
| BIMEVOX        | bismuth metal vanadium oxide                             |
| dc             | direct current   |
| DTA            | differential thermal analysis                            |
| DSC            | differential scanning calorimetry                        |
| FT-IR          | fourier-transform infrared spectroscopy                  |
| HT-            | high-temperature   |
| ICDD           | international centre for diffraction data                |
| ICP-OES        | inductively coupled plasma-optical emission spectrometry |
| LT-            | low-temperature  |
| ppb            | parts per billion  |
| OFN            | oxygen free nitrogen                                     |
| SEM            | scanning electron microscopy                             |
| SD             | standard deviations                                      |
| SOFCs          | solid oxide fuel cells                                   |
| TGA            | thermogravimetry analysis                                |
| XRPD           | x-ray powder diffraction                                 |
| YSZ            | yittria stabilized zirconia                              |
| a, b, c        | cell parameters  |
| A              | area   |
| A*             | complex admittance                                       |
| c              | velocity of light  |
| C              | capacitance  |
| C <sub>b</sub> | bulk capacitance   |